Interview Summary	Application No.	Applicant(s)	
	10/808,081	WHITTTON, MATTHEW D.	
	Examiner	Art Unit	
	IAN JEN	3664	
All participants (applicant, applicant's representative, PTO personnel):			
(1) <u>IAN JEN</u> .	(3) <u>Mr. Reid M. DeManche</u> .		
(2)	(4)		
Date of Interview: 27 August 2009.			
Type: a)⊠ Telephonic b)□ Video Conference c)□ Personal [copy given to: 1)□ applicant 2)□ applicant's representative]			
Exhibit shown or demonstration conducted: d)  Yes e) No. If Yes, brief description:			
Claim(s) discussed: <u>1-11</u> .			
Identification of prior art discussed: Minowa et al(US Pat No 6243637); Narita (US Pat No 5241477).			
Agreement with respect to the claims f) was reached. g) was not reached. h) $\times$ N/A.			
Substance of Interview including description of the general nature of what was agreed to if an agreement was reached, or any other comments: Further discuss with respect to Prior art reference along with applicant's remark were provided. The non-final office action dated on 05/14/2009 is withdrawn with respect to applicant's argument persuasive. Notice of Allowance will be provided accordingly after the withdrawn of non-final office action dated on 05/14/2009.  (A fuller description, if necessary, and a copy of the amendments which the examiner agreed would render the claims			
allowable, if available, must be attached. Also, where no copy of the amendments that would render the claims allowable is available, a summary thereof must be attached.)			
THE FORMAL WRITTEN REPLY TO THE LAST OFFICE ACTION MUST INCLUDE THE SUBSTANCE OF THE INTERVIEW. (See MPEP Section 713.04). If a reply to the last Office action has already been filed, APPLICANT IS GIVEN A NON-EXTENDABLE PERIOD OF THE LONGER OF ONE MONTH OR THIRTY DAYS FROM THIS INTERVIEW DATE, OR THE MAILING DATE OF THIS INTERVIEW SUMMARY FORM, WHICHEVER IS LATER, TO FILE A STATEMENT OF THE SUBSTANCE OF THE INTERVIEW. See Summary of Record of Interview requirements on reverse side or on attached sheet.			

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Supervisory Patent Examiner, Art Unit 3664